





Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/784,260		FUJIBAYASHI, AKIRA	
	Examiner		Art Unit	
	Hiep T. Nguyen		2187	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
711		170		711	162				
INTERNATIONAL CLASSIFICATION				710	56				
G	0	6	F						

 (Assistant Examiner) (Date)		 HIEP T. NGUYEN PRIMARY EXAMINER (Primary Examiner)		Total Claims Allowed: 26	
 (Legal Instruments Examiner)		11-30-05 (Date)		O.G. Print Claim(s) 1	
		11/30/05 (Date)		O.G. Print Fig. 1	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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